Contents

1. Introduction · 1

2. Staff List · 2

3. Instrument List · 3

4. Summary of Instruments · 5

5. Subscription journals · 20

6. CAC Usage Rules · 21

7. Overtime Utilization · 22

8. CAC Web System · 23

9. Reservation Procedures · 24

10. Intramural and extramural cooperation · · · · · · · · · · · · · · · · · 29

11. Pleas from CAC · 30

12. Floor room · 31

1.Introduction

Material Analysis Center (MAC), the predecessor of Comprehensive Analysis Center (CAC), had been established in 1977 as an affiliated facility of The Institute of Scientific and Industrial Research (ISIR). CAC, with the reorganization of MAC integrating the former Electron Microscope Room, was established in 2009 as a common comprehensive facility to support a wide range of basic and applied research fields in ISIR. CAC staffs consist of 1 associate and 2 assistant professors (as full-time professors), 4 technical staffs, 3 part-time staffs, 4 assistant professors (concurrent post) and 1 director (concurrent post).

Fortunately, immediately after the renewal, CAC could update many of decrepit instruments to globally advanced instruments by obtaining a supplementary budget in 2010 to be equipped with observation instruments including component and surface analyzers, spectrometers and electron microscopes, shown in this booklet, to comprehend various research fields in ISIR. The instruments are maintained and managed by CAC staffs to allow users to utilize at any time. CAC staffs support analyses by utilizing instruments required expertise and each researcher can utilize easily operable instruments all day. Lectures for instrument users, including instrumental analysis lectures for new students, is vigorously held every year. Fully utilize the instruments in CAC if you read this booklet and/or CAC users' guide.

CAC is an ISIR-affiliated common facility and primarily positioned as a research support facility in ISIR. Additionally, CAC enhances cooperation with collaborative research facility networks centering on Center for Scientific Instrument Renovation and Manufacturing Support, Osaka University. CAC users consisting of intramural and extramural researchers and Incubation Building-located company workers are currently increasing. CAC was highly evaluated by external evaluations held in 2012 as "an open facility which is a model case in Japan and Osaka University should be proud of".

Above-mentioned performance related to university-wide supports of education and research was recognized in 2015. An expenditure of CAC-proposed project "promotion of university-wide education for material state analysis" has been supported by presidential discretionary expenditure (intensive promotion expenditure for education and research). All CAC staffs make further efforts to effectively utilize the expenditure to allow all users to give excellent research results. The CAC full-time professors conduct their original research related to organic, physical organic and analytical chemistry by fully utilizing instruments in CAC. Additionally, CAC staffs vigorously participate in opening CAC to the public (Icho Festival), tours for high school students and introduction activity of advanced instruments and research.

CAC staffs would appreciate the understanding and cooperation of all users' for maintenance and development.

2.Staff List

Position	Name	Affiliation	Extension	E-mail	Room No Annex of Research Buildings
Director	Nobuo Kato	Department of Organic Fine Chemicals	8470	kato-n *1)	F542
Associate Prof.	Takeyuki Suzuki	Comprehensive Analysis Center (CAC)	8525	suzuki-t *1)	205-1
Assistant Prof.	Dayang Zhou	Comprehensive Analysis Center (CAC)	8529	zhou *1)	206
Assistant Prof.	Kaori Asano	Comprehensive Analysis Center (CAC)	8526	asano *1)	206
Staff	Takeshi Ishibashi	Technical Division	8531	isibasi *1)	S105
Staff	Takanori Tanaka	Technical Division	8397	tanaka *1)	F232
Staff	Tsuyoshi Matsuzaki	Technical Division	8527	matuzaki *1)	302
Staff	Hitoshi Haneoka	Technical Division	8529	haneoka *1)	206
Staff	Yosuke Murakami	Technical Division	8531	murakami *1)	S105
Staff	Mitsuru Fujisaki	Comprehensive Analysis Center (CAC)	8528	fujisaki *1)	206
Staff	Nao Eguchi	Center for Scientific Instrument Renovation	4782	eguchi-n *2)	I405
Assistant Administrative Staff	Etsuko Tani	Comprehensive Analysis Center (CAC)	8529	e.tani *1)	201

*1) @sanken.osaka-u.ac.jp *2) @reno.osaka-u.ac.jp


N. Kato


T. Suzuki


D. Zhou


K. Asano


T. Ishibashi


T. Tanaka


T. Matsuzaki


H. Haneoka


Y. Murakami


M. Fujisaki


N. Eguchi


E. Tani

3.Instrument List

Instrument Name		Model (Maker) Name	Measurement Method		For Self Measurement			Installation Room *2)	Reservation *3)	Details	Staff
			Request	Self	Special Guidance	Reservation	Overtime Utilization *1)				
Nuclear Magnetic Resonance	700 MHz	Avance Ⅲ-700 (BRUKER)	○			Available	Available	105	B	5	D. Zhou H. Haneoka
	600 MHz	Avance Ⅲ-600 (BRUKER)	○					104	B	5	
	600 MHz	ECA-600 (JEOL)	○	○	Required			106	A,B	6	
	400 MHz	ECS-400 (JEOL)		○	Required			F428	A	6	K.Takenaka
	400 MHz	ECS-400 (JEOL)		○	Required			F507	A	6	M.Nitani
Mass Spectrometer		JMS-M600H (JEOL)		○	Required	Available	Available	303	A	7	K. Asano T. Matsuzaki
		JMS-700 (JEOL)	○					303	B	7	
		AccuTOF-DART(JEOL)		○	Required	Available	Available	303	A	8	
		Ultraflex Ⅲ (BRUKER)		○	Required	Available	Available	304	A	8	
		micrOTOF Ⅱ (BRUKER)	Negotiable					304		9	
		Orbitrap XL (THERMO)	○					304	B	9	
		ITQ1100 (THERMO)		○	Required	Available	Available	304	A	10	
Secondary Ion Mass Spectrometer		SIMS4100 (ATOMIKA)		○	Required	Available	Available	102	C	10	T. Suzuki
Infrared Spectrophotometer		FT/IR4100 (JASCO)		○		Available	Available	302	A	11	T. Suzuki
		React-IR45 (METTLER)	Negotiable	○		Available	Available	302	C	11	
Ultraviolet-visible Spectrophotometer		V-770 (JASCO)		○		Available	Available	302	A	12	H. Haneoka
Polarimeter		P-2300 (JASCO)		○		Available	Available	302	A	12	
Inductively Coupled Plasma Spectrometer		ICPS-8100 (SHIMADZU)		○	Required	Available	Available	301	C	13	N. Eguchii H. Haneoka
CHN Element Analyzer		2400 (PERKIN-ELMER)	○					302	B	14	T. Matsuzaki
		JM10 (J-SCIENCS)	○					302			
Differential Thermal Balance		TG8120 (RIGAKU)		○		Available	Available	302	C	14	M. Fujisaki
Differential Scanning Calorimeter		DSC8270 (RIGAKU)		○		Available	Available	302	C	14	

Instrument Name	Model (Maker) Name	Measurement Method		For Self Measurement			Installation Room *2)	Reservation *3)	Details	Staff
		Request	Self	Special Guidance	Reservation	Overtime Utilization *1)				
X-ray Microanalyzer	JXA-8800R (JEOL)	*4) ○	○	Required	Available	Available	102	C	15	Y. Murakami N. Eguchi
Scanning Electron Microscope	S-2150 (HITACHI)		○	Required	Available	Available	102	C	15	
Scanning Electron Microscope	JSM-6330F (JEOL)	*4) ○	○	Required	Available		S107	C	16	Y. Murakami N. Eguchi
Transmission Electron Microscope	JEM-ARM200F (JEOL)	○					S104	D	16	T. Ishibashi M.Nishino R. Aso
	JEM-2100 (JEOL)	○	○	Required	Available	Negotiable	F192	C	17	
Nanoscale Hybrid Microscope	VN-8010 (Keyence)		○	Required	Available	Available	S107	C	17	T. Ishibashi Y. Murakami
X-ray Diffractometer	SmartLab (RIGAKU)	*4) ○	○	Required	Available	Available	203	C	18	M. Fujisaki
Fluorescent X-ray Diffractometer	ZSX100e (RIGAKU)		○	Required	Available	Available	101	C	18	T.goto
X-ray Diffractometer for Single Crystals	AFC-7RCCD (RIGAKU)	*4) ○	○	Required	Available	Available	203	C	19	M. Fujisaki
	AFC-7R4CDX (RIGAKU)	○	○	Required	Available	Available	203			
	FR-E-IP (RIGAKU)	*4) ○	○	Required	Available	Available	203			
	FR-E-AXIS Ⅳ (RIGAKU)	*4) ○	○	Required	Available	Available	203			

*1) “Overtime Utilization” means utilization of CAC expect 8:30-17:30 on weekdays.

(See p.21 for details)

*2) See Floor Map (p.29)

*3) See Reservation A (p.23), Reservation B (p.25), Reservation C (p.26) and Reservation D (p.27).

*4) Request for staffs in Center for Scientific Instrument Renovation.

4.Summary of Instruments

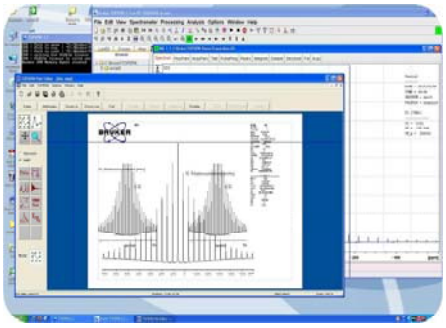
Nuclear Magnetic Resonance 700MHzNMR

ReservatioB

AVANCE III 700, a high resolution NMR spectrometer of Bruker BioSpin, is an advanced digital NMR device at the highest level. Combination of cryoprobes enables supersensitive NMR measurement. The spectrometer has supersensitive triple resonance probes for ^{1}H, ^{13}C and ^{15}N, which optimizes ^{1}H and ^{13}C nuclear measurements, enables high sensitive and rapid 2D and 3D measurements, and remarkably shortens measurement time. The spectrometer has automatic tuning/matching functions and enables fully automatic measurement with rapid and high resolution by simultaneously using sample changers, which is applicable to the various fields including pharmaceutics, biotechnology, organic chemistry, material science etc..

Nuclear Magnetic Resonance 600MHzNMR(solid)

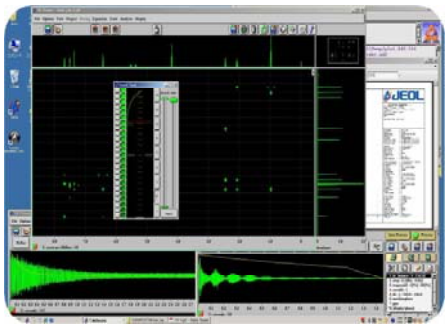
ReservatioB



AVANCE III 600WB, the latest solid NMR spectrometer of Bruker BioSpin, has a wide bore magnet, which enables measurement variable-temperature from -140 to +150°C. Combination of 4-mm CPMAS probes and superhigh speed rotary 1.3-mm CPMAS probes enables proton, multinuclear and 2D NMR measurements difficult for conventional spectrometers. The solid NMR spectrometer at the highest level is applicable to the various fields including material science, life science etc. and determination of solid catalysts.

Nuclear Magnetic Resonance 600MHzNMR

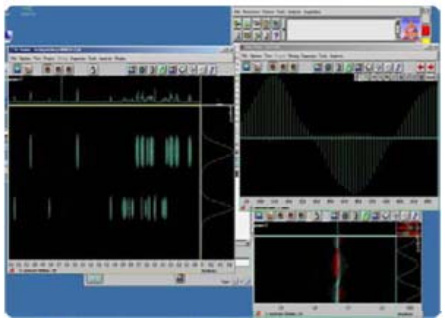
ReservatioA,B



JNM-ECA 600, developed by Japan Electron Optics Laboratory (JEOL), is an FT-NMR spectrometer using the advance digital technology and high frequency. Automatic tuning and matching of JNM-ECA 600 MHz NMR enables gradient shim. The spectrometer easily provides NMR spectra with high reproducibility and quality. The water signal elimination and differential spectrum measurements are also easily measurable. Low frequency probes are also equipped. The spectrometer is applicable to down to rhodium and has an MICCS instrument enabling reaction tracing measurement.

High-sensitive Magnetic Resonance Spectrometer 400MHzNMR

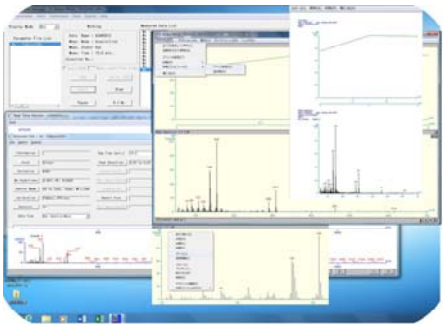
ReservatioA



Two high performance magnetic resonance spectrometers (JNM-ECS 400), developed by Japan Electron Optics Laboratory CO., LTD (JEOL), are smaller size two channels spectrometers for solutions. The spectrometers with space-saving design have SCMs with compact magnetic field. The spectrometers with excellent stability exhibits remarkable effect on elimination of solvent signals and on differential spectrum measurement. The spectrometers are originally equipped with auto-tuning probes which enable to cleanly, quickly and easily measure various NMR spectra. The spectrometers are equipped with data processing software Delta which enables to easily and freely process data. Users also can process NMR data by using analytical software such as Delta, Net Alice etc. through theirs PC in the ISIR.

Mass Spectrometer FAB-MS (JMS-600)

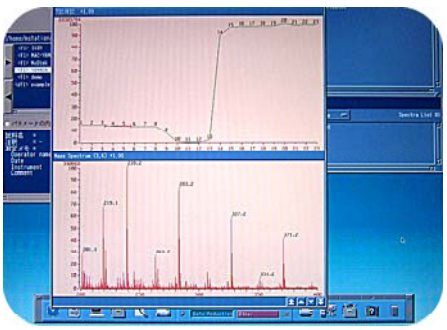
ReservatioA



Fast atom bombardment (FAB) is an ionization technique that the high energy neutral atoms collide with the molecules of material to create ions. The substances of material to be analyzed are mixed with the non-volatile chemical solvent called a “matrix” like m-NBA (3-nitrobenzyl alcohol) commonly used for a standard. And the molecules of the substances are “bombarded” under high-vacuum with a high energy (3 to 10 kV) by the atoms accelerated at high speed and collided. The atoms are typically from an inert gas such as argon (Ar) or xenon (Xe). This instrument in here is applied to low-resolution measurement, and ions can be detected easily. Also it’s usually suitable for *hardly volatile* compounds with mass range of 100-800 m/z.

Mass Spectrometer FAB-MS (JMS-700)

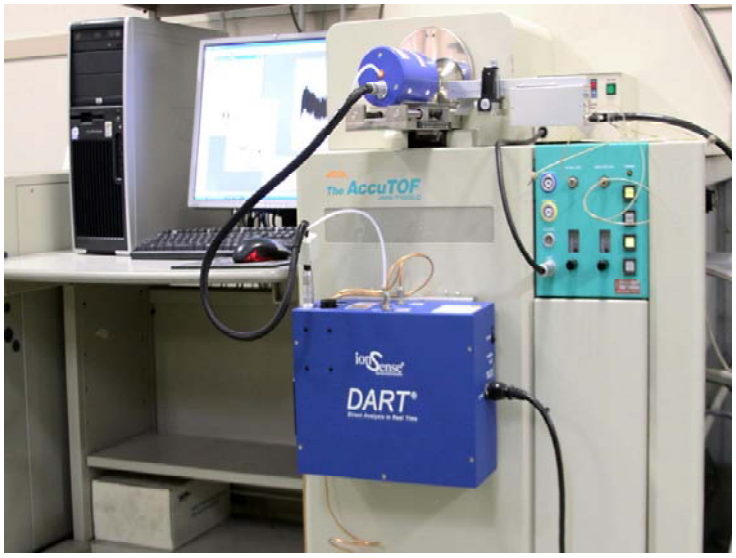
ReservatioB

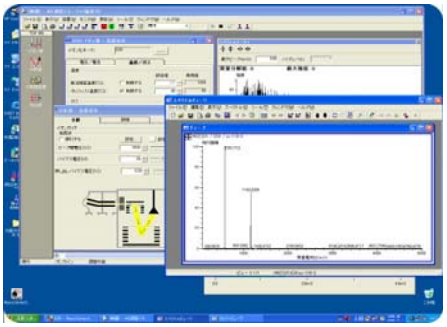


This JMS-700, developed by JEOL, is the reverse geometry (, or BE geometry) double-focusing mass spectrometer of the magnetic field preceding type by which the ion optics system consists of a magnetic field and an electric field. That's the successor model of forward geometry (, or EB geometry) analyzer JMS-600H, and that can tune parameters about condition automatically. Chemical composition can be presumed because of its good-sensitivity and high resolution.

Mass Spectrometer DART-SVP-MS

ReservatioA

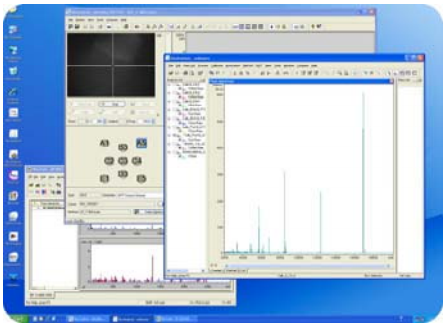




This mass spectrometer has DART (Direct Analysis in Real Time) ion source developed by IonSense Inc., which is interfaced to AccuTOF ™ ESI-TOF mass spectrometry developed by JEOL. DART is an atmospheric pressure ion source that instantaneously ionizes gases, liquids and solids in open air under ambient conditions. It is one of the first Ambient-Ionization techniques. Ambient ionization is a form of ionization in which ions are formed in an ion source outside the mass spectrometer without sample preparation or separation. So, solid and liquid materials can be analyzed by mass spectrometry in their native state.

Mass Spectrometer MALDI-MS

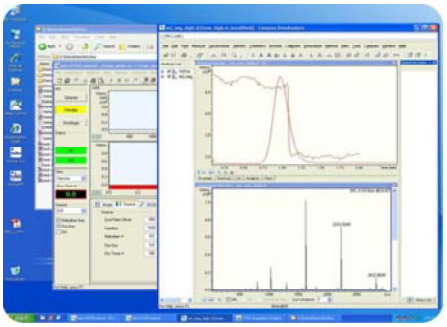
ReservatioA



Ultraflex III ™ developed by BRUKER has Smartbeam ™ as a laser beam to largely enhance sensitivity and resolution. The focus diameter (10 ~ 80 μm) of the laser is possible to control by PC. By using a minimal laser focus, a sample of tissue section can be scanned by a very high pixel in MALDI imaging measurement. And spectral data are obtained with high-sensitivity and high-resolution. The Normal measurement of the spectrometer exhibits a wide mass range of 1 - 500,000 m/z and a high resolution of 25,000 by using PAN ™ (Panoramic) technology.

Mass Spectrometer CSI-MS

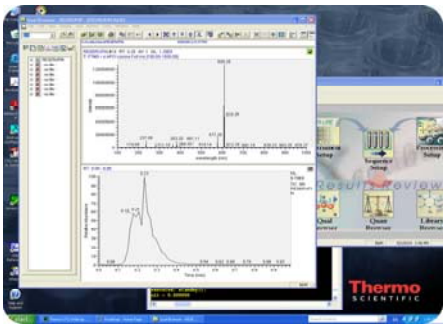
ReservatioNegotiable



This spectrometer has the micrOTOF-II™ combining Cryo-Spray developed by BRUKER, which enables ESI-TOF (electro-spray-ionization time-of-flight) mass-spectrometry measurement under cooled conditions to the high sensitivity and the high-resolution; mass accuracy: 1-2 ppm, mass resolution: 16,500 and measurable mass range: 50 ~ 20,000 m/z . The spectrometer is suitable for organic structures which are unstable at room temperature or sensitive to ambient air: organometallic complexes, supramolecular complexes and reactive intermediates etc..

Mass Spectrometer FT-MS

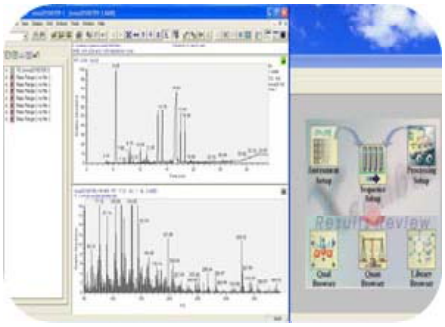
ReservatioB



The Thermo Scientific™ LTQ Orbitrap XL™ Hybrid Ion Trap-Orbitrap Mass Spectrometer is a Fourier Transform Mass Spectrometer (FTMS) based on Thermo Scientific™ LTQ XL™ linear ion trap and Orbitrap mass spectrometer technologies. The spectrometer has high performances with high resolution (60,000 @m/z 400 of resolution), mass range (50-2000, 200-4000 m/z), high mass accuracy (3 ppm), high sensitivity, and dynamic range. Those enable profiling of low-abundance metabolites in complex mixtures and also profiling of protein at multistep MS/MS. ESI, APCI and APPI ionizations are selectable and a wide range of samples is measurable at the highest level.

Mass Spectrometer GC-MS

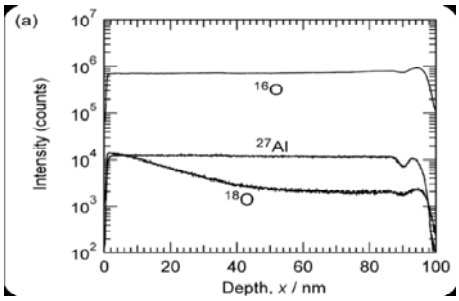
ReservatioA



A member of the Thermo Scientific ITQ™ Series of GC-ion trap mass spectrometers, the ITQ 1100™ GC/MS^n (measurable mass range: 10-1100 m/z) enables MS^n (MS/MS, $n \leq 5$). The ITQ 1100 has new advanced scan-function of "ACE (Automated Collision Energy) and PQD (Pulsed Q Dissociation Mode)". The advantages of its functions are easier to optimize analysis and data quality is improved. It acquires full scan and MS^n data in a single acquisition simultaneously. ITQ 1100 restores the performance without venting by using the standard vacuum probe interlock.

Secondary Ion Mass Spectrometer SIMS4100

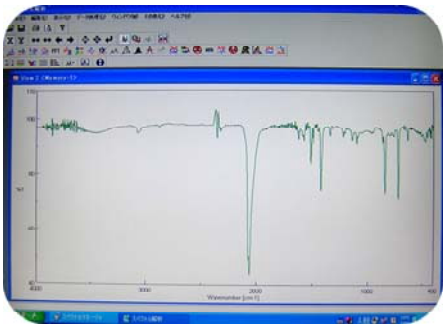
ReservatioC



This secondary ion mass spectrometer, developed by ATOMIKA, irradiates primary ion beams to solid surfaces of samples. A quadrupole mass spectrometer in the spectrometer detects secondarily released ions by sputtering. Mass spectrometry of secondary ions enables highly sensitive (ppm-ppb) identification of constituent elements of the samples on the solid surfaces. Appropriately using oxygen or cesium as a primary ion source corresponding to analyzed elements affords depth-directional distribution of the elements by measuring chronological changes of intensity of secondary ion signals.

Fourier Transformation Infrared Spectrophotometer FT-IR

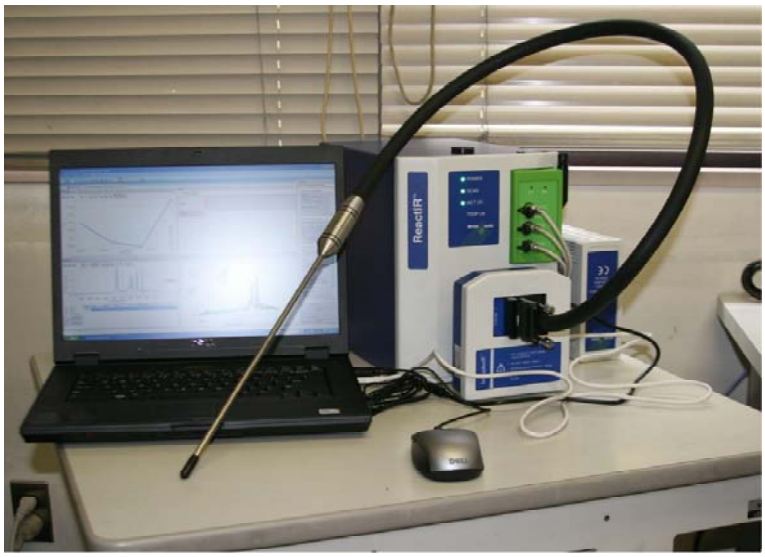
ReservatioA

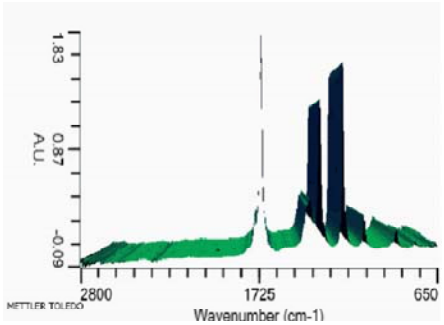


This compact infrared spectrophotometer Fourier-transforms interference waves by PC, which has high sensitivity, stability and easy operability and is suitable for routine analysis. The spectrophotometer has ATR (Attenuated Total Reflection) measuring instrument, which is applicable to film and powder samples. The spectrophotometer enables middle, near and far infrared measurements, which afford infrared absorption spectra from a wide range of both inorganic and organic samples. Furthermore, the spectrophotometer is applicable to rapid scanning and imaging measurements, which enables to utilize for research and material development.

Infrared Spectrometer React IR

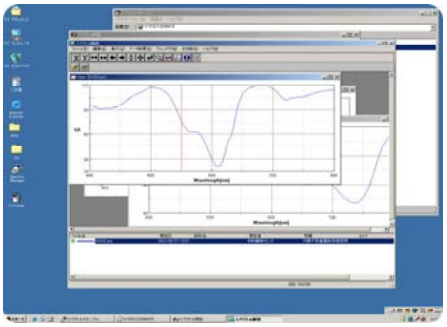
ReservatioC





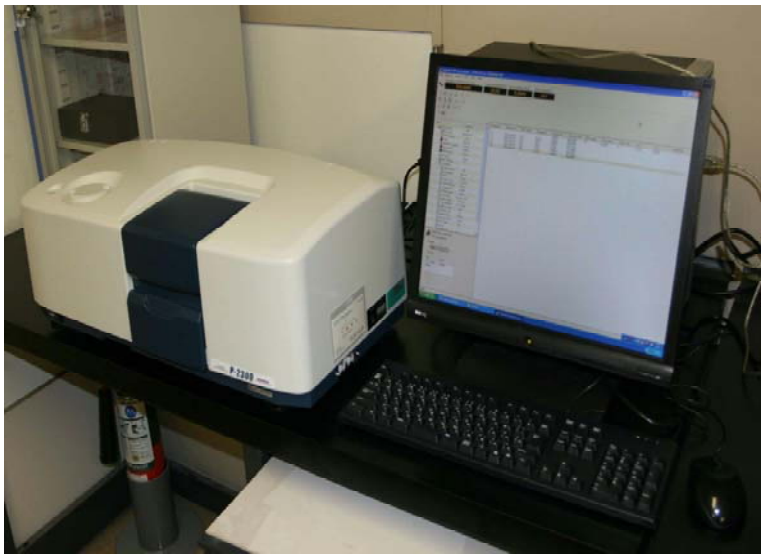
This spectrometer enables continuous measurement for the shortest time of every 5 seconds, which continuously monitor various changes in a solution by showing infrared spectra. The spectrometer is effective for analysis of reaction mechanisms due to identifiability of reaction intermediates existing only during chemical reactions and observability of the extinction rate of starting materials and the formation rate of products from changes of peak intensities.

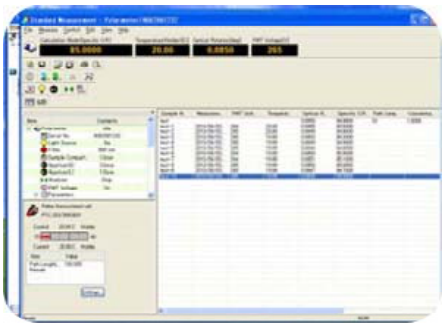
Ultraviolet-visible Near Infrared Spectrophotometer UV・Vis・NIR ReservatioA



This spectrophotometer enables continuous measurements between ultraviolet and near infrared regions. The spectrophotometer has automatically switchable detectors by measurement wavelengths: a photomultiplier tube for the ultraviolet and visible regions, and a PbS detector for the near infrared region. Using an integrating sphere enables diffuse reflection measurement of solid surfaces and diffuse transmission measurement of suspension. Most of incident light to the sample, reflected and/or transmitted in all directions, is acquired by the integrating sphere, which enables accurate measurement.

Polarimeter P-2300 ReservatioA

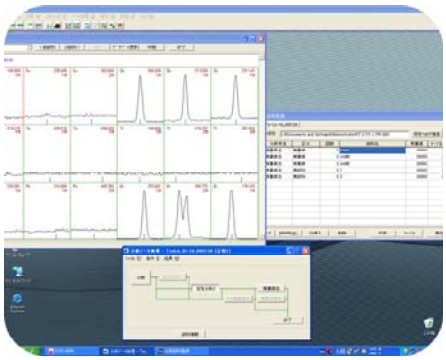




This polarimeter has both sodium and mercury lamps and a Glan-Taylor prism as a polarizer. The measurement wavelength is selectable from 589, 578, 546, 436 and 365 nm. The polarimeter has various types of cells, which enables to measure samples of at least 100 µl. Highly accurate measurement under temperature control by using an air-cooling Peltier cell is also performable.

Inductively Coupled Plasma Spectrometer ICP

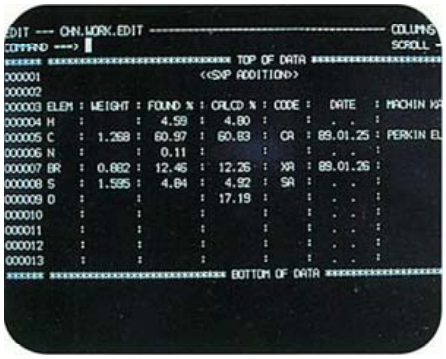
ReservatioC



This top-class ICP emission spectrometer has 2 sequential scanning spectrometers, which exhibits both high resolution and high speed. Plasma energy from the spectrometer excites component elements in samples. The spectrometer measures emission rays of the excited elements transiting to the lower energy levels. The spectrometer enables a wide range of highly accurate analyses including ppb-level analysis of trace elements in a solution and high concentration analysis such as composition analysis. Rapid simultaneous quantitative analysis of multiple elements is also performable.

Organic Trace Element Analyzer CHN

ReservatioB



Elemental analysis is a classical and important quantitative analysis and purity test, which determines a weight percentage of elements composing pure samples including organic compounds by combustive and oxidative decomposing the pure samples. The analysis is mainly applied to confirmation of synthetic chemicals and determination of the structure of natural compounds. Stable and highly pure samples afford highly accurately analytical values. Measurable elements are carbon, hydrogen and nitrogen.

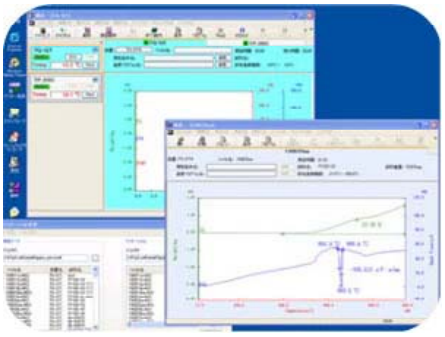
Element Analyzer CHN

ReservatioB

Elemental analysis is a classical and important quantitative analysis and purity test, which determines a weight percentage of elements composing pure samples including organic compounds by combustive and oxidative decomposing the pure samples. The analysis is mainly applied to confirmation of synthetic chemicals and determination of the structure of natural compounds. Stable and highly pure samples afford highly accurately analytical values. Measurable elements are carbon, hydrogen and nitrogen. Ash content is also quantifiable.

Thermal Analyzer TG-DTA,DSC8270

ReservatioC



Thermal analysis is variously applicable to characterization of substances, which easily affords accurate analytical information from relatively small amount of samples, which is essential for research related to materials, polymers, petroleum products andbiosubstances. Combination of the thermal analysis with EPMA and PXD, installed in CAC, enables better evaluation of solid materials. This differential thermal balance TG8120/high temperature infrared heater TG-DTA of Thermo plus EVO II/TG-DTA series, developed by Rigaku, has a service temperature from room temperature to 1500°C and the maximum temperature elevation rate of 1000°C /min. The analyzer has a high temperature differential scanning calorimeter DSC8270 and enables simultaneous measurement of TG-DTA and DSC.

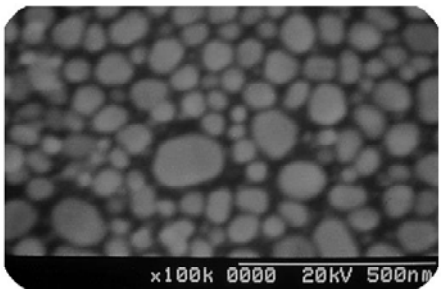
X-ray Microanalyzer EPMA

ReservatioC

EPMA (Electron Probe Micro-Analyzer) finely narrows generated electron beams from an LaB_6 electron gun to tens nanometers and accelerates the beams to up to 40 kV to irradiate the surface of solid samples. Determination of elements composing the samples and quantitative analysis of the samples are performable based on the wavelength of characteristic X-rays generated from the samples. Mapping measurement indicating element distribution states and linear analysis are also performable. The EPMA has measurability of B ～ U, 8 analyzing crystals and 4 detectors. Measurability of cathode luminescence is characteristic of the EPMA. The EPMA exhibits remarkable effect on evaluation of metals, minerals, ceramics, semiconductor materials etc.

Scanning Electron Microscope SEM

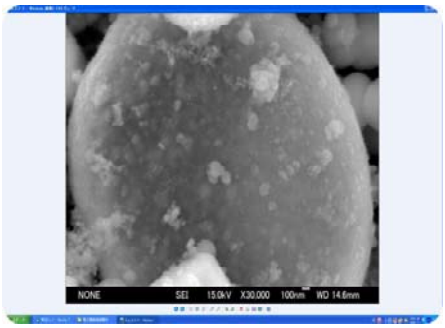
ReservatioC



Irradiating finely narrowed electron beams on solid surfaces generates secondary electrons. The electron beams on the surfaces of samples are scanned to be observed.

Scanning Electron Microscope FE-SEM+EDS

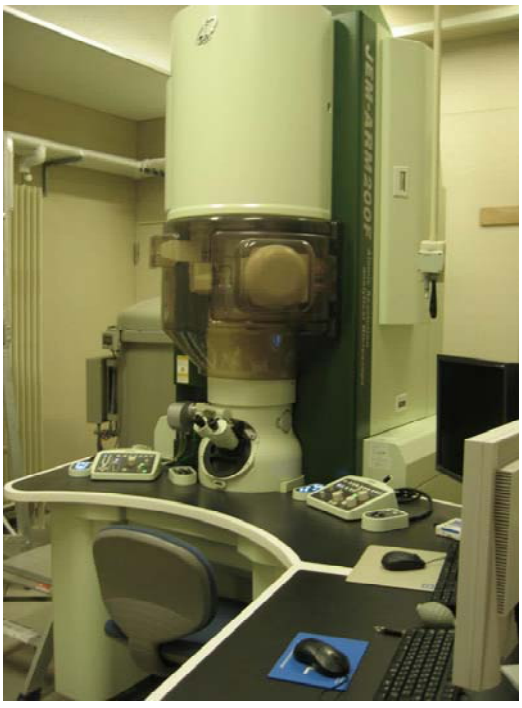
ReservatioC

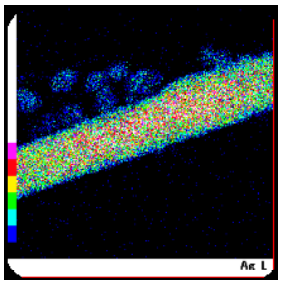


Scanning electron microscope (SEM) for analysis (JSM-6335F) has resolution of ~1 nm (15 kV) and acceleration voltage of 1~30 kV. A characteristic X-ray detector in an element analyzer in the SEM is required no liquid nitrogen supply and cooled by a Peltier element. The SEM has detectability of Be~U and energy resolution of 138 eV or less. Appropriately using carbon coater or osmium coater according to purposes enables to acquire clear images. Attending a lecture on FE-SEM+EDS are reguired to use.

Transmission Electron Microscope JEM-ARM200F

ReservatioD

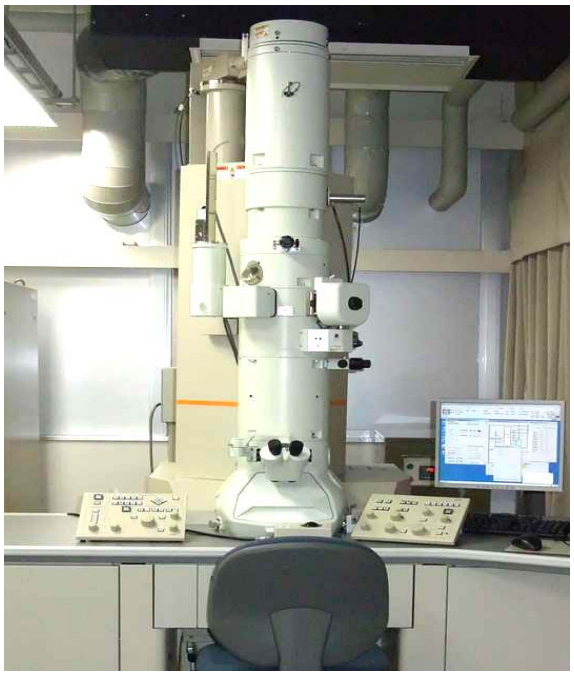


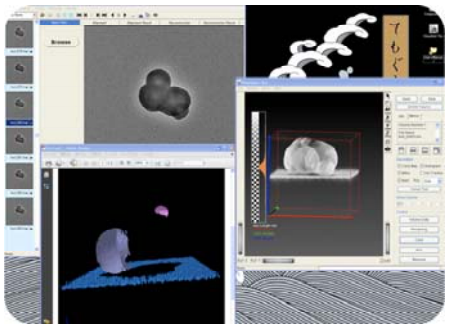


This microscope is a Schottky emission electron gun equipped with a ZrO/W emitter as a cathode, which has higher brightness and a smaller electron source than a thermionic electron gun and affords higher current stability and larger probe current than a field emission electron gun by heating at the high temperature of 1800 K. Negative spherical aberration coefficients obtained by an attached spherical aberration corrector (Cs corrector) counteract positive spherical aberration coefficients obtained by a condenser lens having a symmetrical axis of a magnetic field, which enables to acquire smaller and higher intensity probes and to analyze elements with higher resolution. Detecting electrons transmitted through film samples acquires STEM images affording scattering/absorption, diffraction and phase contrasts.

Transmission Electron Microscope 3 D-TEM

ReservatioC

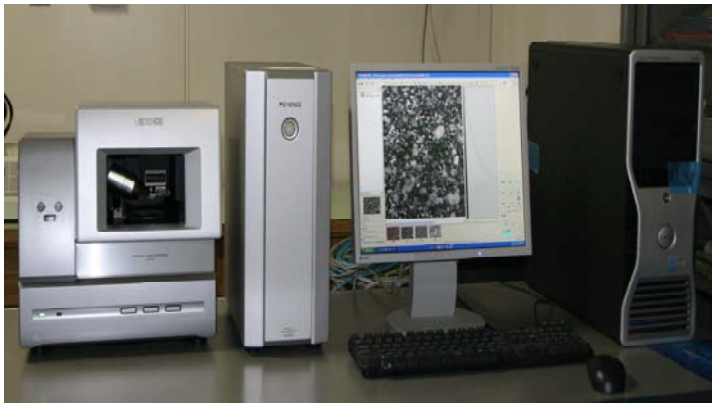




LaB_6 electron gun-equipped transmission electron microscope (200 kV) (JEM-2100) enables high resolution and high contrast observation, which is suitable for observation of biological samples. CCD camera enables to photography TEM images as digital data. High-tilt holder enables to set the tilt angle of samples to up to ±80°. TEM tomography system enables to automatically acquire continuously tilted images. 3D reconstruction of samples and visualization of 3D structures are performable by PC.

Nanoscale Hybrid Microscope VN-8010

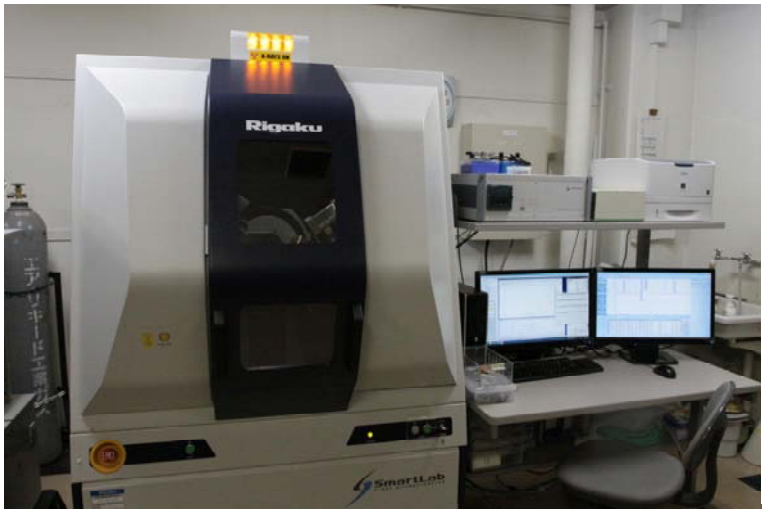
ReservatioC

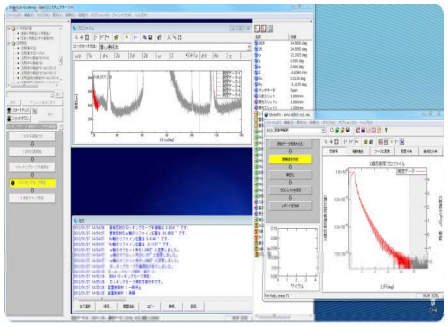


This new type microscope combines a digital microscope and AFM, which enables nano region observation of optical microscopic images by mouse operation. The optical microscope enables nano-scale identification of the AFM observation position. Obtained AFM data enables to observe surface roughness and sectional shapes. Observation and analysis are readily performable for even beginners by following "e-guidance".

X-ray Diffractometer XRD

ReservatioC





This multipurpose diffractometer measures scattered and diffracted X-rays generated from solid samples by irradiating strong X-rays (45kV, 200mA, Cu), which exhibits remarkable effect on film samples. The diffractometer is applicable to in-plane, film thickness, orientation, particle and void size distribution, and rocking curve measurements. Following guidance function allows users including beginners to easily obtain data. Choosing an incident X-ray source from Ge double crystals or Ge quadruple crystals enables high resolution measurement. The diffractometer has a scintillation detector, a one-dimensional detector enabling fast measurement within several minutes, and ICDD (Ver2. 1102).

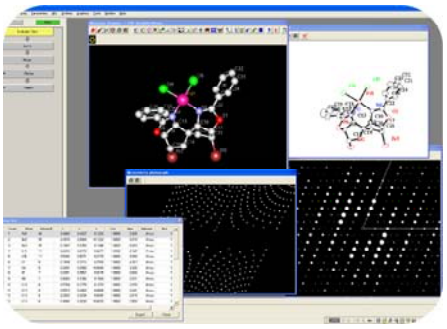
Fluorescent X-ray Diffractometer ZSX-100e

ReservatioC

This wavelength dispersion X-ray diffractometer (WDX) was transferred to CAC, through a courtesy of prof. Tohru SEKINO, ISIR. A vacuum tube (Rh) of 4kW used as an X-ray source in the WDX diffracts fluorescent X-rays generated from samples to 5 analyzing crystals (LiF1, PET, Ge, RX-25 and RX-75). Two detectors (scintillation counter and gas flow proportional counter) in the WDX enable highly sensitive qualitative and quantitative analyses of various elements (from F to U). The WDX corresponds to powder, bulk and liquid samples. Continuous measurement (turret-type measurement) enables simultaneous measurement of up to 12 samples. The WDX has SQX program performing semi-quantification by FP method without standard samples through qualitative analysis results, and EZ scanning mode allowing users including inexperienced users to perform SQX analysis without instruction manuals.

X-ray Diffractometer for Single Crystals 4CXD

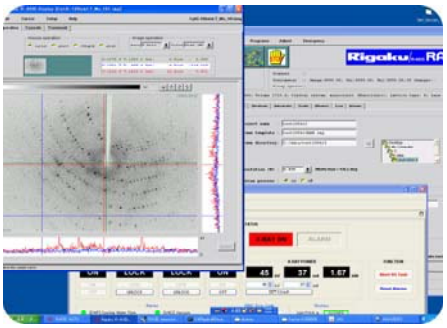
ReservatioC



This diffractometer irradiates strong X-rays (60 kV, 300 mA) with a single wavelength to single crystal of organic or inorganic compound, which highly accurately and automatically collect intensity of diffracted X-rays generated from respective lattice alignment surfaces of the crystals. The diffractometers have 2 goniometers for measuring diffraction data positions: a four-circle type for highly accurate measurement and an imaging plate type for fast measurement. The respective goniometers have sample temperature controllers which afford data with minimal fluctuation of molecules. Three-dimensional molecular and crystal molecular packing structures are minutely determined from the data.

X-ray Diffractometer for Single Crystals IP

ReservatioC



This diffractometer using Cu as an X-ray source enables to determine the absolute structure of organic low molecules, which is also suitable for crystals having a large lattice constant. High brightness mirrors attached to the diffractometer enables to secure a 10 or more time higher bright X-ray source than an X-ray source of rotary anticathode X-ray generator (18 kW) and to collect data of fine crystal. The diffractometer has a curved IP detector unit having a resolution of more than 150° in terms of 2θ and RAPID-AUTO as software.

5.Subscription Journals

CAC subscribes to the following journals. Data collections are also available. The journals and data collections are available in 201 and 206 in CAC. If you want to read them, please feel free to ask CAC staffs.

Journals

1) ANALYTICAL CHEMISTRY 1929 ~ 1972, 1978 ~ 2006
2) Bunseki Kagaku 1952 ~
3) Shitsuryo Bunseki 1982 ~ 2006
4) Bunseki 1975 ~
5) Journal of The American Society for Mass Spectrometry 1996 ~ 2006
6) Advances in X-ray Chemical Analysis Japan 1974 ~

Data collections

1) ICDD (International Centre for Diffraction Data) ~ Set 56
2) Handbook of Proton-NMR Spectra and Data. Vol. 1-10 (1985), Academic Press.
3) Carbon-13 NMR Spectral Data, Fourth Edition, Microfiche Collection. Vol. 1-3 (1987), Equipment for Microfiche Reader, VCH (medium)
4) EPA/NIH Mass Spectral Data Base. Vol. 1 (1987) - 4 Suppl. 2 (1983), NSRDS
5) Molecular Structures and Dimensions. Vol. 1 (1970) - Vol. 15 (1984),
   Crystallographic Data Center, Cambridge

Videos for learning analysis [物質の科学・有機構造解析 (Material Science and Organic Structural Analysis), The Open University of Japan]

CAC Pamphlet, CAC Users' Guide

6.CAC Usage Rules

Please utilize the all instruments in CAC by following CAC usage rules.

- Opening Hours: 8:30 ~ 17:30 (except Saturdays, Sundays and national holidays)
- Utilization of CAC: Procedures under "CAC Web System" is required (p.22).
  (Access to "CAC Web System" in a webpage of CAC.)
- Overtime Utilization: ISIR card is required for utilization of CAC after 17:30 on weekdays, and all days on Saturdays, Sundays and national holidays (p.21).
- No street shoes allowed (the entire building): Use dedicated slippers in footwear boxes in the entrance.
- No smoking: The entire building
- Reprinting: Published articles describing research results have to contain acknowledgements and the reprinted articles have to be submitted to CAC. →The articles are exhibited at the entrance of CAC.

  (e.g.) We thank the members of the Comprehensive Analysis Center, ISIR, Osaka University, for spectral measurements, X-ray diffraction data, and microanalyses.

7.Overtime Utilization

ISIR card is required to utilize CAC during 17:30 to 8:30 on weekdays, and all days on Saturdays, Sundays and national holidays.

1. ISIR-issued ID card (Figure 1) is required to enter and exit CAC and laboratories during overtime utilization. Be sure to have the ID card.
2. Unlock/lock a door by holding the ID card (Figure 1) over an electronic lock controller (Figure 2).
3. The electronic lock controller is contactless, which enables to use the ID card even left in a wallet etc.
4. An electronic lock of a laboratory is automatically locked after entering the laboratory. When leaving the laboratory, unlock the electronic lock from the inside of the laboratory.
5. Left an opened door over 30 seconds sounds an alarm. The alarm is stopped and the door is locked when the closed door is confirmed.
6. All electronic locks are unlocked when unexpected power failure happens.
7. In emergency, uncover an emergency cover for the electronic lock of the inside of the entrance or open an emergency exit in every floor to exit.

Figure 1

Figure 2

8.CAC Web System

All instruments are required to access to "CAC Web System". Access to the system from the dedicated PC near an instrument or a PC set in each laboratory. The procedure is as follows;

1)Click "CAC Web System" in a webpage (top page) of CAC.

2)Enter User and Password in the left side of a screen of CAC Web System (Figure 3) to login.

(Click "Create an account" if you use the system for the first time.)

3)Appropriately choose a measurement method shown in a screen (Figure 4).

4)Choose items for each measurement method by following an output screen of the measurement method.

5)When finishing the input to the system, click Logout in the left side of the screen.

Note: The system is automatically disconnected by left no operation of the system over 30 minutes. Re-login to re-access to the system.

Figure 3

Figure 4

9.Reservation Procedures

Reservation A (ECA-600, ECS-400, JMS-M600H, AccuTOF-DART, Ultraflex Ⅲ, ITQ1100, FT/IR4100, V-770, P-2300)

・Self Measurement (Start/Stop type)

1)After the login, click “分析手法で選ぶ (choose a measurement method)”. Click “自主測定(Self Measurement)” (P.22, Figure 4).

2)Click "Start" button when starting measurement (Figure 5). Choose a utilization time in the following screen (Figure 6). Click "Submit" button.

3)Click "Stop" button when finishing the measurement (Figure 7). Choose Method and Solvent (In case of NMR Figure 8) (number of samples for mass spectrometers, Figure 9) in the following screen. Enter a comment if needed. Click "Submit" button.

*If the next user is waiting, please contact the next user by telephone.

4) Click "Waiting" button if the instrument is "Busy". Choose a utilization time in the following screen. Click "Submit" button.

5) If you perform measurement on a specific date and time or long-time measurement at night, choose the date and time for reservation. Click "Reserve" button. Choose a utilization time in the following screen. Click "Submit" button.

*Performing "Reserve" is available for a reservation after 3 hours or later from the present time.
Perform "Waiting" for a reservation within 3 hours from the present time.

Figure 5

Figure 6

Figure 7

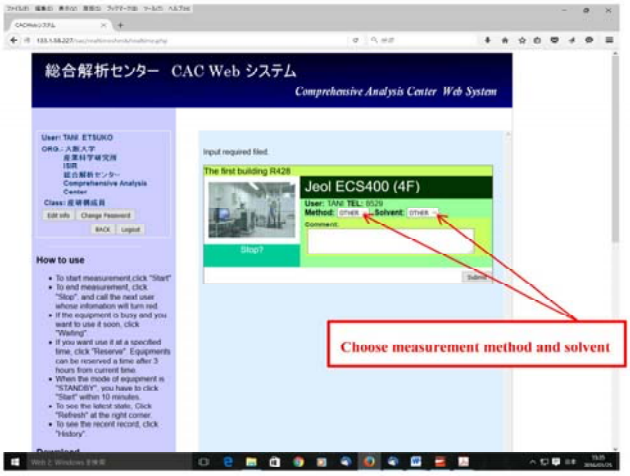


Figure 8

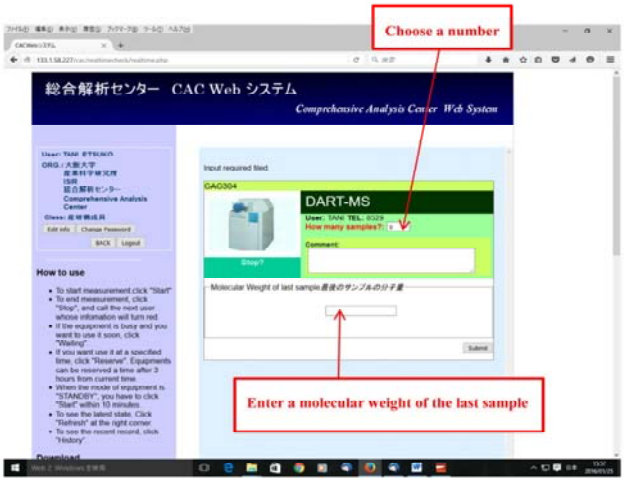


Figure 9

Reservation B (Avance III-700, Avance III-600, ECA-600, JMS-700, OrbitrapXL, CHN Organic Trace Element Analyzer, DX-AQ)

・Request Measurement

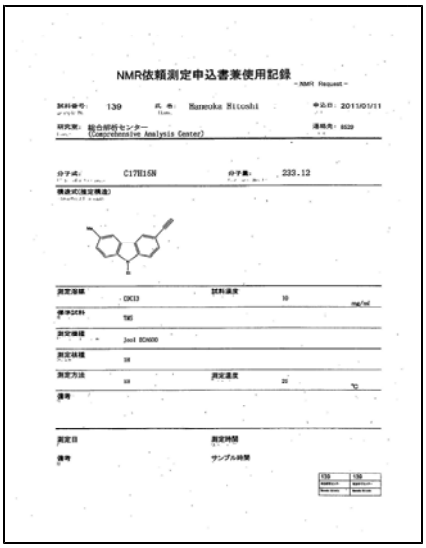
Request measurement is available for special measurement methods and nuclides and/or users with no utilization experience.

1)After the login, click “分析手法で選ぶ (choose a measurement method)”. Click “依頼測定 (Request Measurement)” (P.22, Figure 4).

2)Enter information about a sample and attach structure file. Click ”依頼 (Request)” (Figure 10).

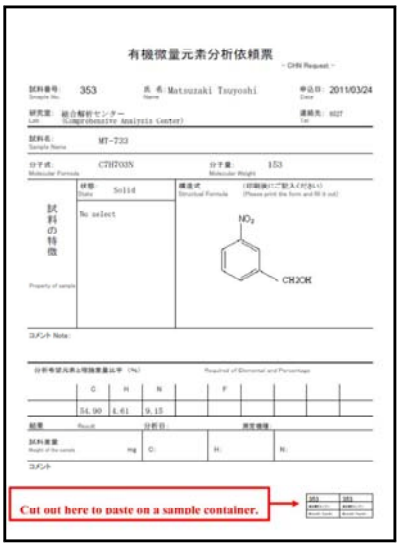
3)A record with the information about the sample is created (Figure 11). Print out and submit the 1record with a sample to a staff of the measurement.

Figure 10



Record for NMR (example)

Record for Mass Spectrometers (example)



Record for Organic Trace Element Analyzers (example)

Figure11

Reservation C (SIMS4100, React-IR45, ICPS-8100, TG8120, DSC8270, JXA-8800R, S-2150, JSM-6330F, JEM-2100, VN-8010, ZSX100e, SmartLab, AFC-7RCCD, AFC-7R4CDX, FR-E-IP, FR-E-AXIS Ⅳ)

・Self Measurement (Calendar type)

1)After the login, click “分析手法で選ぶ (choose a measurement method)”. Click “自主測定(Self Measurement)” (P.22, Figure 4).

2) Choose a reservation date and time from the displayed calendar. Click “予約 (Reserve)” (Figure12).

*Colored boxes of the dates indicate utilization status of the instrument.

(red: reserved for all day, yellow: partially reserved, white: reservable, green: today)

*Mouseover operation on the boxes enables to display reserver's name and reservation details in theright screen.

3) Click MOD button to modify the reservation or DEL button to delete the reservation. MOD button and DEL button are in the right screen (Figure 13).

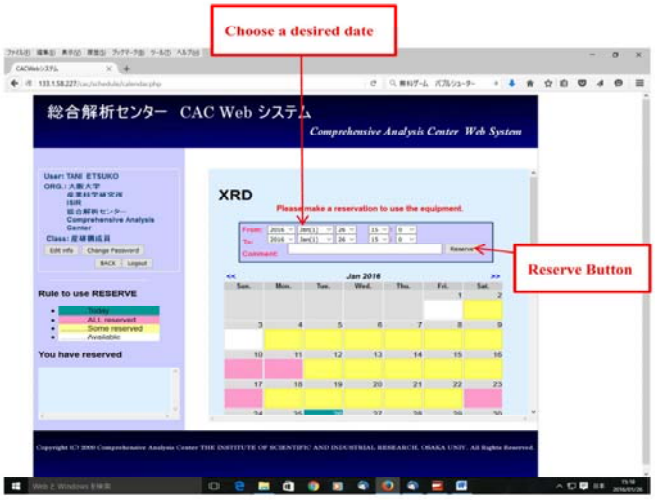


Figure 12

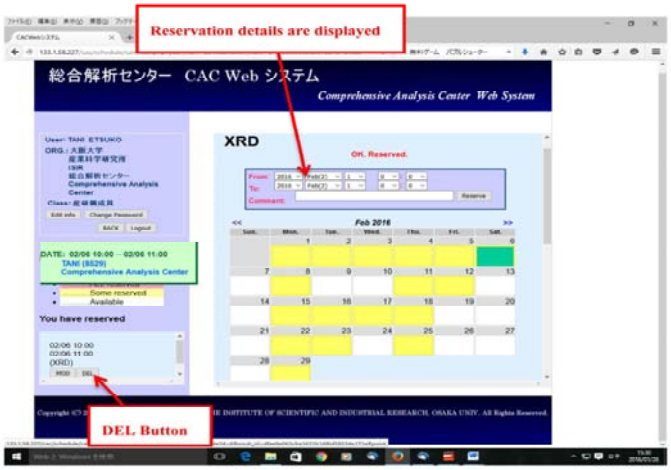


Figure 13

Reservation D (JEM-ARM200F)

Utilization of transmission electron microscope for the following week is reservable from 10 am on every Thursdays in room 105 in the 2nd Building.

*Utilizing JEM-ARM200F is not reservable by accessing to CAC Web System.

(a) Request Measurement

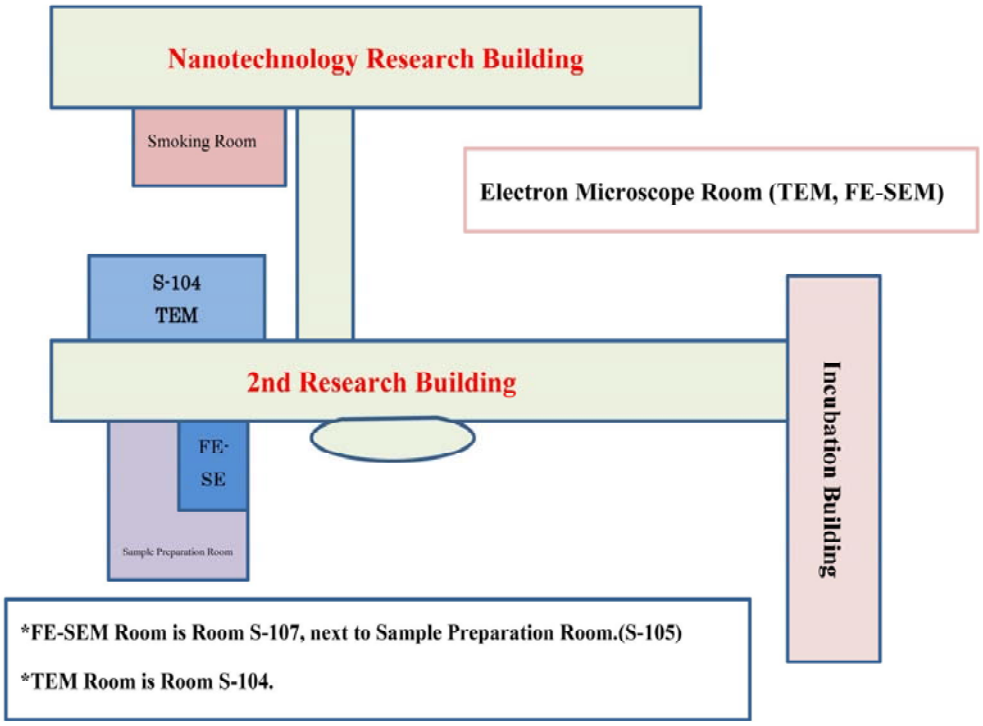
・Please feel free to discuss measurement and preparation method for samples. Please come in Room 105 (Sample Preparation Room) in the 2nd Building.

(b) Self Measurement

・Fulfill the both following requirements; utilization experience of any electron microscopes and permission by a CAC staff (Ishibashi).

(c) Sample preparation

・A lecture on the sample preparation is held if needed.



10.Intramural and Extramural Cooperation

A part of instruments in CAC is served for intramural and extramural cooperation by cooperating with Center for Scientific Instrument Renovation. Center for Scientific Instrument Renovation, with the developmental reorganization of Manufacturing Center, was established in the 1st of April, 2007. Fundamental instruments for research and education, with conventional supports of "manufacturing", research and education by Manufacturing Center, are repaired, restored and reborn to promote "reuse promotion" with intramural cooperation between staffs and students. Six of all CAC-owned instruments, including high-frequency inductively coupled plasma emission spectrometer (ICP), X-ray diffractometer for single crystals etc., are currently served for intramural cooperation with Center for Scientific Instrument Renovation as a window. Lectures on the services are also held. Two instruments (ICP and EPMA) of the six instruments have been started extramural services by cooperating with Center for Scientific Instrument Renovation since this year.

Center for Scientific Instrument Renovation　http://www.reno.osaka-u.ac.jp/index.htm

Collaborative Research Facility Network, former Effective Utilization Network for Chemistry Research Facility, centering on Institute for Molecular Science, National Institutes of Natural Sciences in 2007, promotes extramural cooperation. The network in the western Kinki region is positioned in Osaka University.
Prof. Sasai, the previous director of former MAC, continues to be the chairperson of the network of the western Kinki region. See the following webpage for details.

Collaborative Research Facility Network　http://chem-eqnet.ims.ac.jp/index.html

11.Pleas from CAC

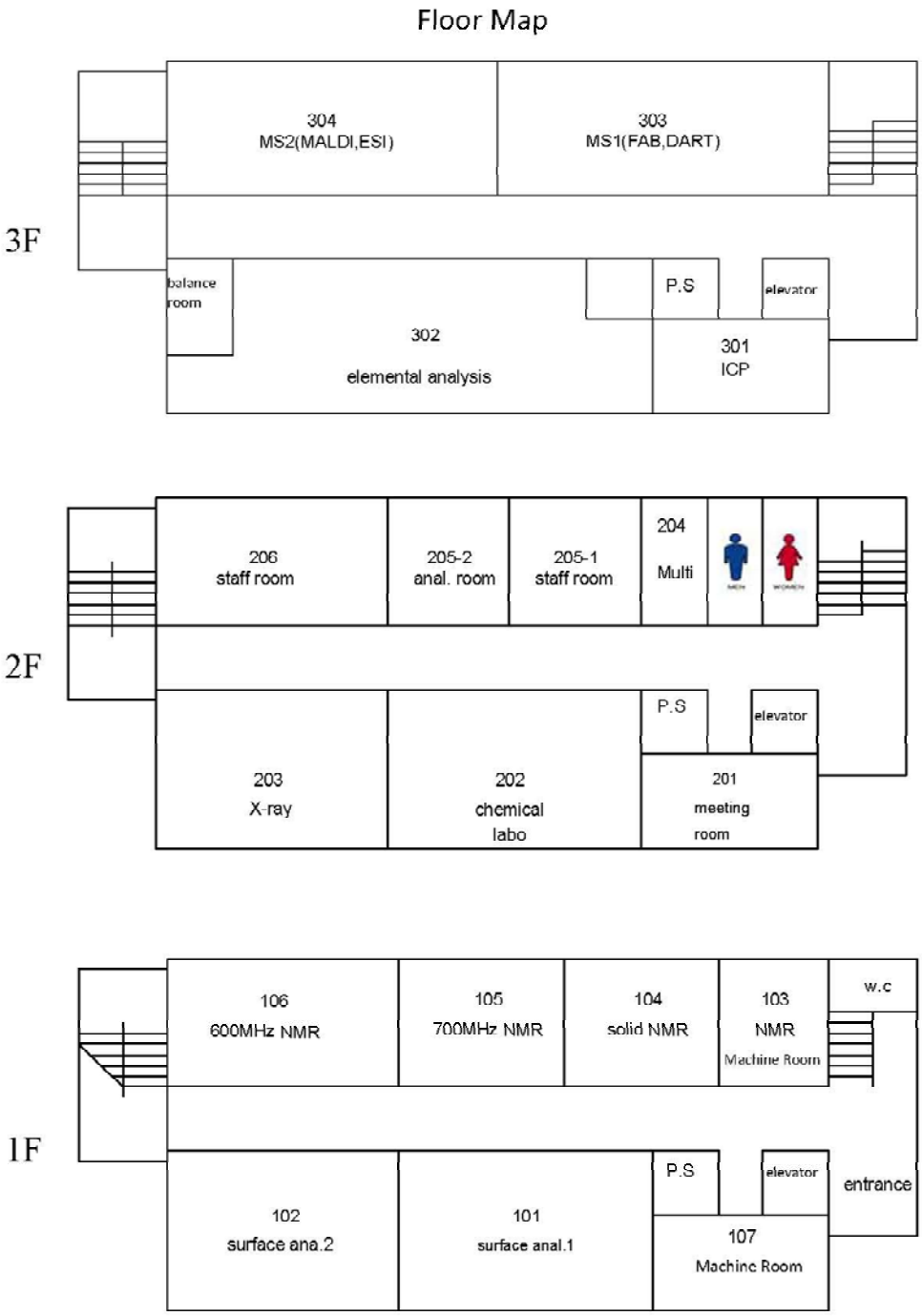
Contributions to research in CAC have to be persuasively exhibited due to transforming Osaka University into a national university corporation.

When articles describing research results acquired by using instruments in CAC are submitted, the articles have to contain acknowledgements (See p.11 of CAC Users' Guide). Additionally, when the articles are printed and published, submit one reprint of each of the articles to CAC.

CAC annually publishes CAC Information with research results acquired by using the instruments in CAC. The reprinted articles are exhibited at the entrance of the 1st floor of CAC. The articles have been favorably received by not only CAC users but also CAC visitors including high school students.

CAC staffs wish furthermore developments of research of all users' by using the instruments in CAC

12.Floor Map


Floor Map
3F
304
MS2(MALDI,ESI)
303
MS1(FAB,DART)
balance room
302
elemental analysis
P.S
elevator
301
ICP
2F
206
staff room
205-2
anal. room
205-1
staff room
204
Multi
203
X-ray
202
chemical labo
P.S
elevator
201
meeting room
1F
106
600MHz NMR
105
700MHz NMR
104
solid NMR
103
NMR
Machine Room
w.c
102
surface ana.2
101
surface anal.1
P.S
elevator
107
Machine Room
entrance